## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10565555	HAYASHI ET AL.
Examiner	Art Unit

4171

SEARCHED					
Class	Subclass	Date	Examiner		
106	31.01-31.97	3/29/2008	/V.N./		
347	100, 101, 86, 96, 54	3/29/2008	/V.N./		
523	160, 161	3/29/2008	/V.N./		
428	32.38	3/29/2008	/V.N./		

Vu Nguyen

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with D. Lawrence Tarazano	3/29/2008	/V.N./		
See EAST search report	5/22/2008	/V.N./		
Inventor search (eDan, PALM, EAST)	3/29/2008	/V.N./		
Consulted with D. Lawrence Tarazano	5/21/2008	/V.N./		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20080522